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2N2880

APPLICATIONS:

- Fast Switching
- High Frequency Switching and Amplifying

FEATURES:

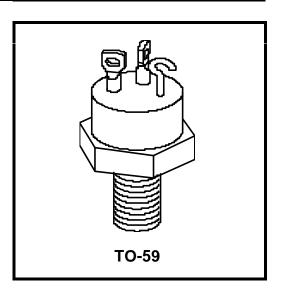
- High Reliability
- · Greater Gain Stability

5 Amp, 80V, Planar, NPN Power Transistors JAN,JTX,JANTXV,JANS

DESCRIPTION:

These power transistors are produced by PPC's DOUBLE DIFFUSED PLANAR process. This technology produces high voltage devices with excellent switching speeds, frequency response, gain linearity, saturation voltages, high current gain, and safe operating areas. They are intended for use in Commercial, Industrial, and Military power switching, amplifier, and regulator applications.

Ultrasonically bonded leads and controlled die mount techniques are utilized to further increase the SOA capability and inherent reliability of these devices. The temperature range to 200°C permits reliable operation in high ambients, and the hermetically sealed package insures maximum reliability and long life.



ABSOLUTE MAXIMUM RATINGS

SYMBOL	CHARACTERISTIC	VALUE	UNITS
V _{CBO} *	Collector-Base Voltage	110	V
V _{CEO} *	Collector-Emitter Voltage	80	V
V _{EBO} *	Emitter-Base Voltage	8	V
I _C *	Continuous Collector Current	5	Α
I _B *	Continuous Base Current	0.5	Α
T _{STG} *	Storage Temperature	-65 to 200	∘C
T _J *	Operating Junction Temperature	-65 to 200	∘ C
*	Lead Temperature 1/16" From Case for 10 Sec.	230	∘C
P _T *	Power Dissipation $T_A = 25^{\circ}C$ $T_C = 100^{\circ}C$	2 30	W W
θ ЈС	Thermal Resistance Junction to Case	3.33	°C/W

^{*} Indicates MIL-S-19500/315





ELECTRICAL CHARACTERISTICS (25°Case Temperature Unless Otherwise Noted)

SYMBOL	CHARACTERISTIC	TEST CONDITIONS	VAI	VALUE	
		TEST CONDITIONS	Min.	Max.	Units
BV _{CBO} *	Collector-Base Voltage	$I_C = 10 _{\mu} Adc$, Cond. D	110		Vdc
BV _{CEO} *	Collector-Emitter Voltage (Note 1)	I _C = 0.1 Adc, Cond. D	80		Vdc
BV _{EBO} *	Emitter-Base Voltage	I _E = 10 μAdc, Cond. D	8		Vdc
I _{CEO} *	Collector-Emitter Cutoff Current	V _{CE} = 60 Vdc, Cond. D		20	μ Adc
I _{CEX} *	Collector-Emitter Cutoff Current	V _{CE} = 110 Vdc, V _{EB} = 0.5 Vdc, Cond. A V _{CE} = 80 Vdc, V _{EB} = 0.5 Vdc, Cond. A, T _A = 150°C		1.0 50	μ Adc μ A
I _{CBO} *	Collector-Base Cutoff Current	V _{CB} = 80 Vdc, Cond. D V _{CB} = 60 Vdc, Cond. D, T _A = - 150°C		0.2 10	μ Adc
I _{EBO} *	Emitter-Base Cutoff Current	V _{EB} = 6 Vdc, Cond. D		0.2	μ Adc
hFE*	DC Current Gain (Note 1)	$\begin{split} I_C &= 50 \text{ mAdc, } V_{CE} = 5 \text{ Vdc} \\ I_C &= 1 \text{ Adc, } V_{CE} = 5 \text{ Vdc} \\ I_C &= 5 \text{ Adc, } V_{CE} = 5 \text{ Vdc} \\ I_C &= 1 \text{ Adc, } V_{CE} = 5 \text{ Vdc, } T_A = -55^{\circ}\text{C} \end{split}$	40 40 15 15	120 120 	
hFE*	AC Current Gain	I _C = 50 mAdc, V _{CE} = 5 Vdc, f = KHz	40	120	
V _{CE(sat)} *	Collector Saturation Voltage (Note 1)	I _C = 1 Adc, I _B = 0.1 Adc I _C = 5 Adc, I _B = 0.5 Adc		0.25 1.5	Vdc Vdc
V _{BE(sat)*}	Base Saturation Voltage (Note 1)	I _C = 1 Adc, I _B = 0.1 Adc		1.2	Vdc
V _{BE(on)} *	Base On-Voltage (Note 1)	I _C = 1 Adc, V _{CE} = 2 Vdc		1.2	Vdc
f _T *	Gain-Bandwidth Product	I _C = 1 Adc, V _{CE} = 10 Vdc, f = 10 MHz	30	120	MHz
C _{ob} *	Output Capacitance	V _{CB} = 10 Vdc, 1 _E = 0, f = 1 MHz		150	pf
td*	Delay Time	I _C = 1 A, I _{B1} = I _{B2} = 100 ma		60	ns
tr*	Rise Time	I _C = 1 A, I _{B1} = I _{B2} = 100 ma		300	ns
ts*	Storage Time	I _C = 1 A, I _{B1} , = I _{B2} = 100 ma		1.7	μS
tf*	Fall Time	I _C = 1 A, I _{B1} = I _{B2} = 100 ma		300	ns
I _{S/B} *	Forward-Biased	V _{CE} = 20 Vdc, t = 10 Sec, T _C = 100°C	1.5		Adc
	Second Breakdown	V _{CE} = 80 Vdc, t = 10 Sec, T _C = 100°C	80		mAdc
E _{S/B} *	Clamped Reverse- Biased Second Breakdown	$I_C = 5$ A, L = 1 mH, $V_{Clamp} = 110$ V, $T_C = 100$ °C $I_B = 0.5$ A, $R_{BB2} = 20$ Ω, $V_{BB2} = -3.0$ V	12.5		mj
E _{S/B} *	Unclamped Reverse-	I _C = 5 A, L = 1 mH, Base Open	12.5		mj
	Biased Second Breakdown	I _C = 1.6 A, L = 10 mH, Base Open	12.8		mj

Note 1: Pulse Test: PW = $300\mu s$, Duty Cycle $\leq 2\%$.

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PACKAGE MECHANICAL DATA

